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Measurement procedure for the assessment of specific absorption rate of human exposure to radio frequency fields from hand-held and body-mounted wireless communication devices –

**Part 1528: Human models, instrumentation, and procedures
(Frequency range of 4 MHz to 10 GHz)**



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IEC Central Office
3, rue de Varembe
CH-1211 Geneva 20
Switzerland
Tel.: +41 22 919 02 11
info@iec.ch
www.iec.ch

Institute of Electrical and Electronics Engineers, Inc.
3 Park Avenue
New York, NY 10016-5997
United States of America
stds.ipr@ieee.org
www.ieee.org

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

MEASUREMENT PROCEDURE FOR THE ASSESSMENT OF SPECIFIC ABSORPTION RATE OF HUMAN EXPOSURE TO RADIO FREQUENCY FIELDS FROM HAND-HELD AND BODY-MOUNTED WIRELESS COMMUNICATION DEVICES –

Part 1528: Human models, instrumentation, and procedures (Frequency range of 4 MHz to 10 GHz)

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International Standard IEC/IEEE 62209-1528 has been prepared by IEC technical committee 106: Methods for the assessment of electric, magnetic and electromagnetic fields associated with human exposure, in cooperation with the International Committee on Electromagnetic Safety of the IEEE Standards Association, under the IEC/IEEE Dual Logo Agreement.

This first edition of IEC/IEEE 62209-1528 cancels and replaces IEC 62209-1:2016, IEC 62209-2:2010, IEC 62209-2:2010/AMD1:2019 and IEEE Std 1528-2013. This edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- a) extension of the frequency range down to 4 MHz and up to 10 GHz;
- b) testing of devices with proximity sensors;
- c) application specific phantoms;
- d) device holder specifications;
- e) fast SAR testing procedures;
- f) test reduction procedures;
- g) LTE assessment procedure;
- h) revision of validation clause, including validation antennas;
- i) revision of SAR assessment procedure;
- j) time-average SAR measurement procedure;
- k) uncertainty analysis;

This publication is published as an IEC/IEEE Dual Logo standard.

This publication contains attached files in the form of the Fast SAR Wizard described in 7.9.2.2 as well as CAD files for the SAM phantom. These files are available at:

http://www.iec.ch/dyn/www/f?p=103:227:0:::FSP_ORG_ID,FSP_LANG_ID:1303,25.

These files are intended to be used as a complement and do not form an integral part of the publication.

The text of this standard is based on the following IEC documents:

FDIS	Report on voting
106/514/FDIS	106/520/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

International Standards are drafted in accordance with the rules given in the ISO/IEC Directives, Part 2.

The IEC Technical Committee and IEEE Technical Committee have decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC web site under "<http://webstore.iec.ch>" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

IMPORTANT – The 'colour inside' logo on the cover page of this publication indicates that it contains colours which are considered to be useful for the correct understanding of its contents. Users should therefore print this document using a colour printer.

INTRODUCTION

The objective of this document is to provide procedures for measuring the human exposure from devices intended to be used at a position near the human head or body. It was developed to provide procedures to evaluate electromagnetic field (EMF) exposures due to radio frequency (RF) transmitting devices used next to the ear, in front of the face, mounted on the body, operating in conjunction with other RF-transmitting and non-transmitting devices or accessories (e.g. belt-clips), or embedded in garments. The types of devices dealt with include but are not limited to mobile telephones, cordless telephones, cordless microphones, and radio transmitters in personal computers. The applicable frequency range is from 4 MHz to 10 GHz. The document defines:

- measurement system requirements (Clause 6),
- SAR measurement protocols (Clause 7),
- SAR measurement uncertainty evaluation (Clause 8), and
- reporting requirements (Clause 9).

At the time this document was developed, two computational and measurement joint IEC/IEEE projects dealing with millimetre-wave power density assessment were under development, covering the frequency range from 6 GHz to 300 GHz. Hence there is an overlap of frequency between this document, which deals with SAR, and the other joint IEC/IEEE projects dealing with power density from 6 GHz to 10 GHz. The IEC/IEEE joint working group was aware of this fact and believed that it would give the flexibility of using whatever metrics suitable for the considered case of compliance assessment.

MEASUREMENT PROCEDURE FOR THE ASSESSMENT OF SPECIFIC ABSORPTION RATE OF HUMAN EXPOSURE TO RADIO FREQUENCY FIELDS FROM HAND-HELD AND BODY-MOUNTED WIRELESS COMMUNICATION DEVICES –

Part 1528: Human models, instrumentation, and procedures (Frequency range of 4 MHz to 10 GHz)

1 Scope

This document specifies protocols and test procedures for the reproducible and repeatable measurement of the conservative exposure peak spatial average SAR (psSAR) induced inside a simplified model of the head and the body by radio-frequency (RF) transmitting devices, with a defined measurement uncertainty. These protocols and procedures apply to a significant majority of the population, including children, during the use of hand-held and body-worn wireless communication devices. These devices include single or multiple transmitters or antennas, and are operated with their radiating structure(s) at distances up to 200 mm from a human head or body. This document is employed to evaluate SAR compliance of different types of wireless communication devices used next to the ear, in front of the face, mounted on the body, operating in conjunction with other RF-transmitting, non-transmitting devices or accessories (e.g. belt-clips), or embedded in garments. The applicable frequency range is from 4 MHz to 10 GHz. Devices operating in the applicable frequency range can be tested using the phantoms and other requirements defined in this document.

The device categories covered include, but are not limited to, mobile telephones, cordless microphones, and radio transmitters in personal, desktop and laptop computers, for multi-band operations using single or multiple antennas, including push-to-talk devices. This document can also be applied for wireless power transfer devices operating above 4 MHz.

This document does not apply to implanted medical devices.

2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 62209-3:2019, *Measurement procedure for the assessment of specific absorption rate of human exposure to radio frequency fields from hand-held and body-mounted wireless communication devices – Part 3: Vector measurement-based systems (Frequency range of 600 MHz to 6 GHz)*.

ISO/IEC Guide 98-3:2008, *Uncertainty of measurement – Part 3: Guide to the expression of uncertainty in measurement (GUM:1995)*

3 Terms and definitions

For the purposes of this document, the following terms and definitions apply.

ISO, IEC, and IEEE maintain terminological databases for use in standardization at the following addresses:

- IEC Electropedia: available at <http://www.electropedia.org/>